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[SUD40N02-3M3P-E3](#)

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sales@integrated-circuit.com

New Product



SUD40N02-3m3P

Vishay Siliconix

N-Channel 20-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	r _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ)
20	0.0033 at V _{GS} = 10 V	40	30 nC
	0.0044 at V _{GS} = 4.5 V	40	

FEATURES

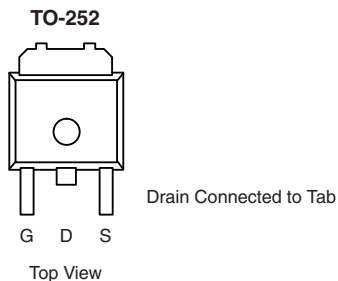
- TrenchFET® Power MOSFET
- 100 % R_g Tested

APPLICATIONS

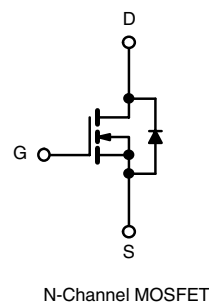
- Server



RoHS
COMPLIANT



Order Number:
SUD40N02-3m3P-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	± 20	
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C	I _D	40 ^a	A
	T _C = 100 °C		40 ^a	
	T _A = 25 °C		24.4 ^b	
	T _A = 100 °C		17.2 ^b	
Pulsed Drain Current		I _{DM}	100	A
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	40 ^a	
	T _A = 25 °C		2.8 ^b	
Maximum Power Dissipation	T _C = 25 °C	P _D	79	W
	T _C = 100 °C		39.5	
	T _A = 25 °C		3.3 ^b	
	T _A = 100 °C		1.6 ^b	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	37	45	°C/W
Maximum Junction-to-Case	Steady State	R _{thJC}	1.5	1.9	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

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SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	20			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = 250 μA		21		mV/°C
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)} /T _J			- 6.9		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1		3	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V			1	μA
		V _{DS} = 20 V, V _{GS} = 0 V, T _J = 100 °C			20	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	30			A
Drain-Source On-State Resistance ^a	r _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		0.0027	0.0033	Ω
		V _{GS} = 4.5 V, I _D = 20 A		0.0036	0.0044	
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 20 A		100		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		6520		pF
Output Capacitance	C _{oss}			1430		
Reverse Transfer Capacitance	C _{rss}			770		
Total Gate Charge	Q _g	V _{DS} = 10 V, V _{GS} = 10 V, I _D = 50 A		105	160	nC
		V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 50 A		50	75	
Gate-Source Charge	Q _{gs}			17		
Gate-Drain Charge	Q _{gd}			14		
Gate Resistance	R _g	f = 1 MHz		1.2	1.9	Ω
Turn-On Delay Time	t _{d(on)}	V _{DD} = 10 V, R _L = 0.2 Ω I _D ≅ 50 A, V _{GEN} = 4.5 V, R _g = 1 Ω		40	60	ns
Rise Time	t _r			30	45	
Turn-Off Delay Time	t _{d(off)}			67	101	
Fall Time	t _f			33	50	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 10 V, R _L = 0.2 Ω I _D ≅ 50 A, V _{GEN} = 10 V, R _g = 1 Ω		13	20	
Rise Time	t _r			7	11	
Turn-Off Delay Time	t _{d(off)}			40	60	
Fall Time	t _f			9	14	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			40	A
Pulse Diode Forward Current ^a	I _{SM}				100	
Body Diode Voltage	V _{SD}	I _S = 20 A		0.81	1.2	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 50 A, di/dt = 100 A/μs, T _J = 25 °C		38	57	ns
Body Diode Reverse Recovery Charge	Q _{rr}			34	51	nC
Reverse Recovery Fall Time	t _a			18		ns
Reverse Recovery Rise Time	t _b			20		

Notes:

a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

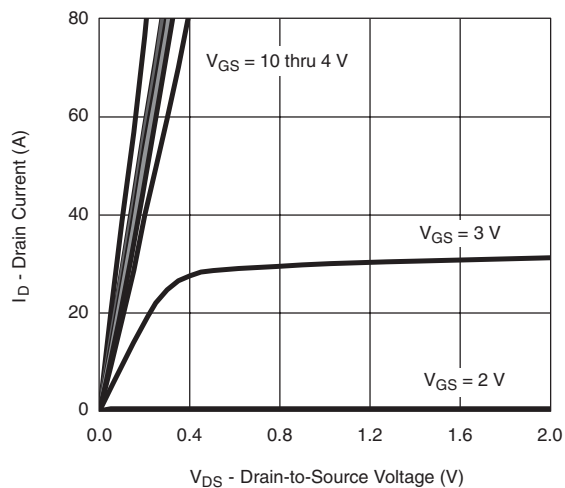
New Product



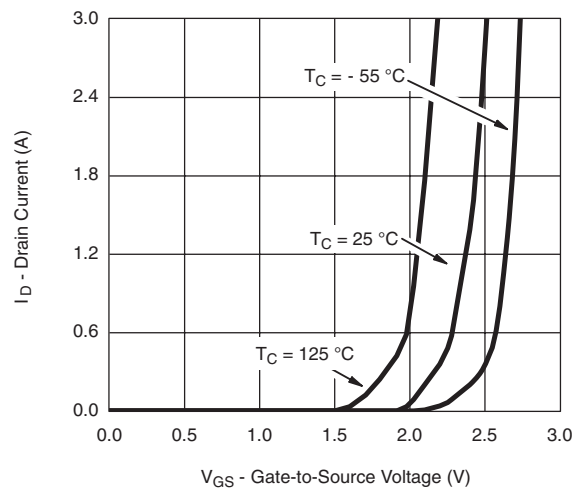
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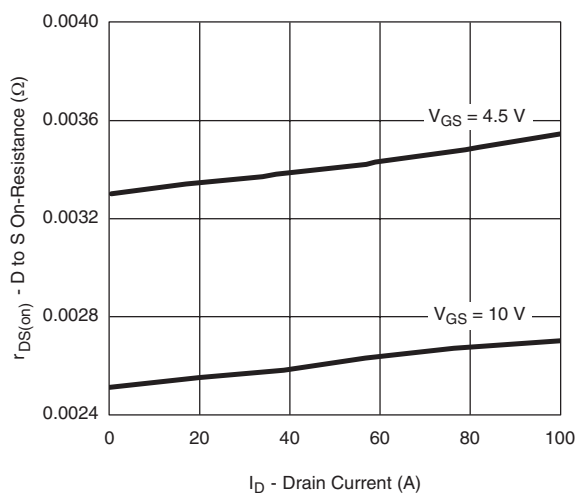
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



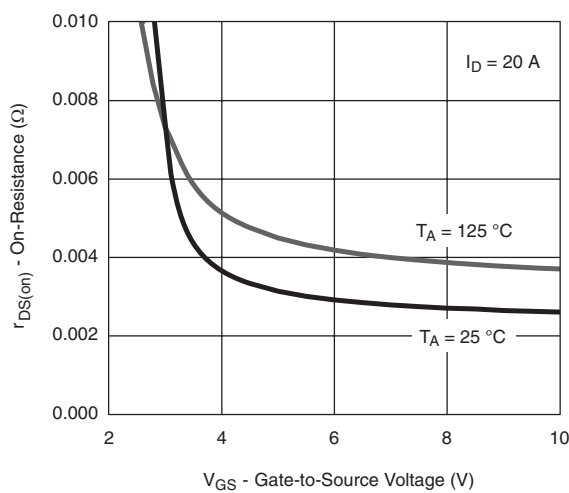
Output Characteristics



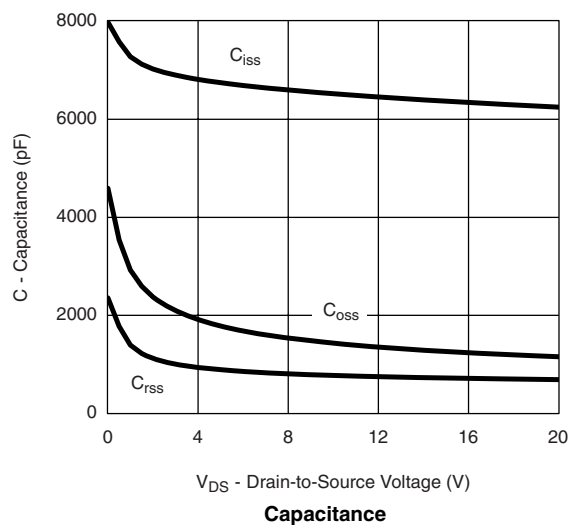
Transfer Characteristics



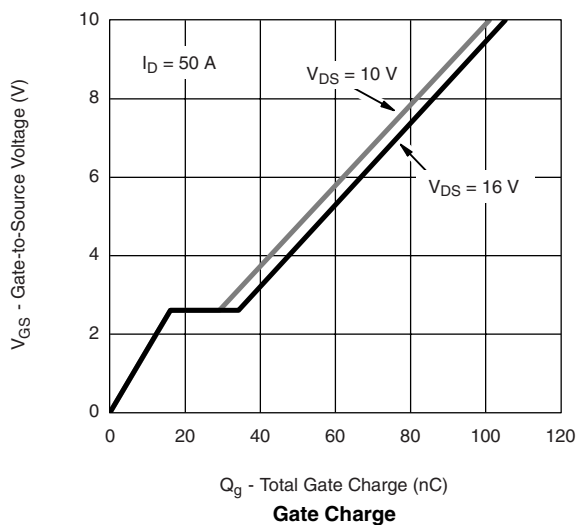
On-Resistance vs. Drain Current



On-Resistance vs. V_{GS} vs. Temperature



Capacitance



Gate Charge

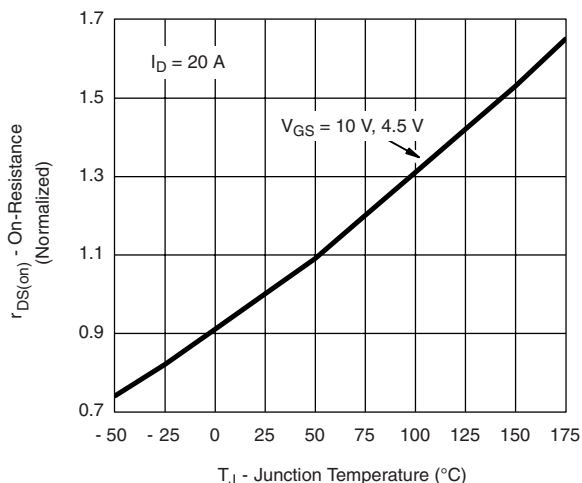
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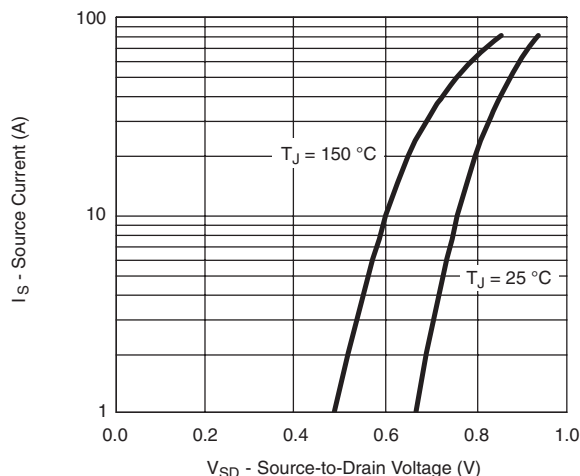
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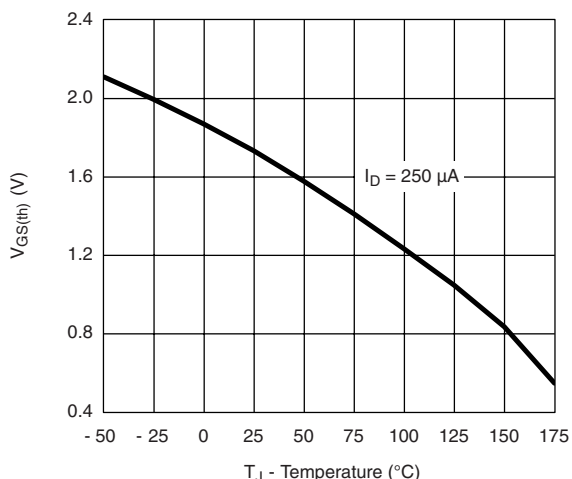
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



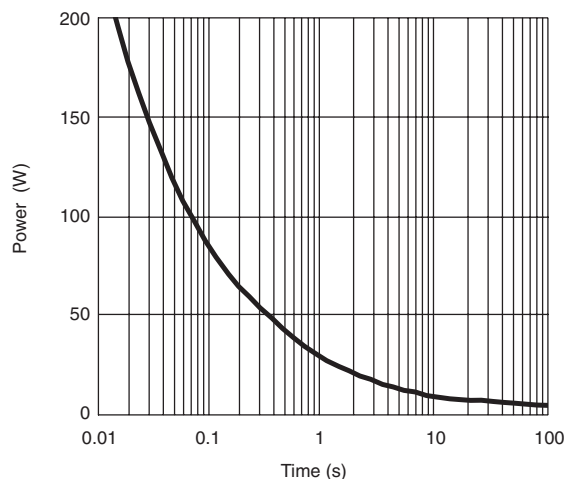
On-Resistance vs. Junction Temperature



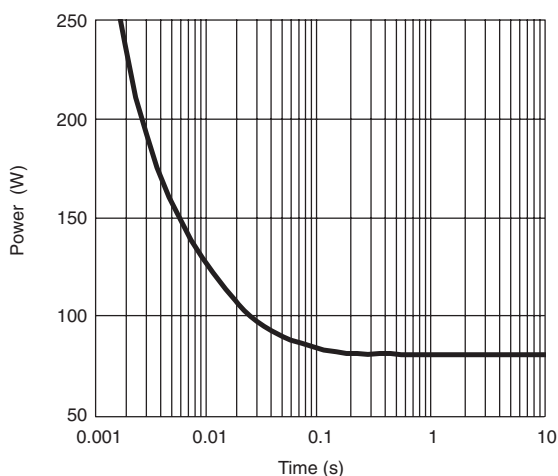
Forward Diode Voltage vs. Temperature



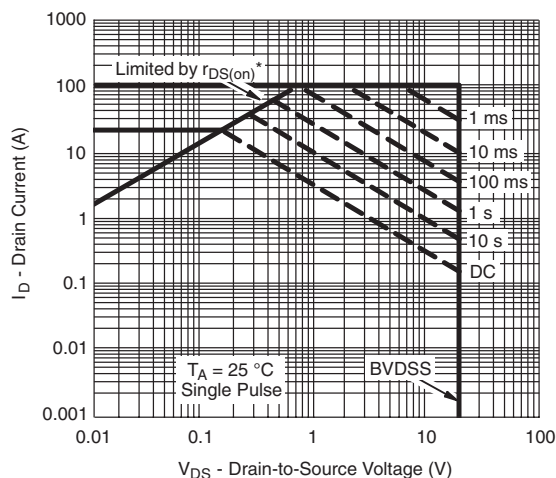
Threshold Voltage



Single Pulse Power, Junction-to-Ambient



Single Pulse Power, Junction-to-Case



* $V_{GS} >$ minimum V_{GS} at which $r_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

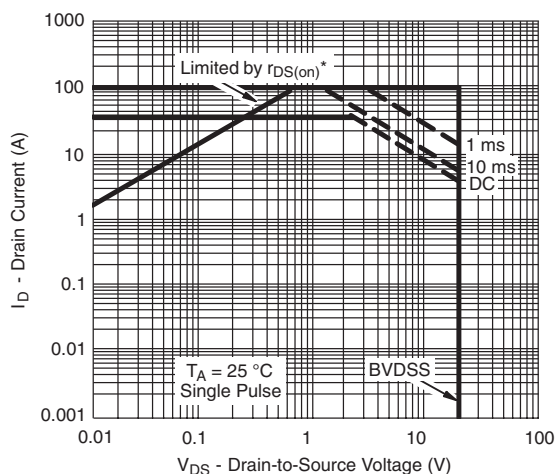
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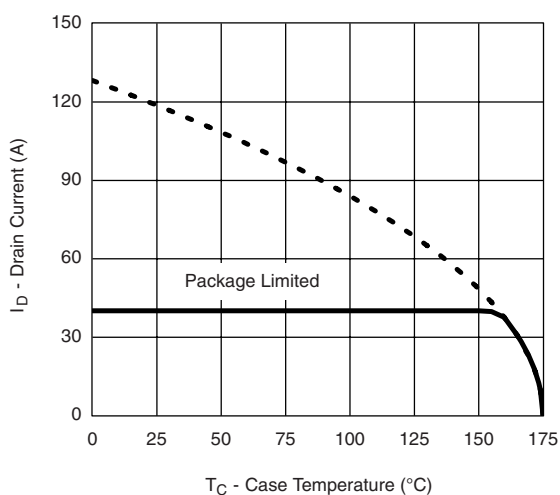
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

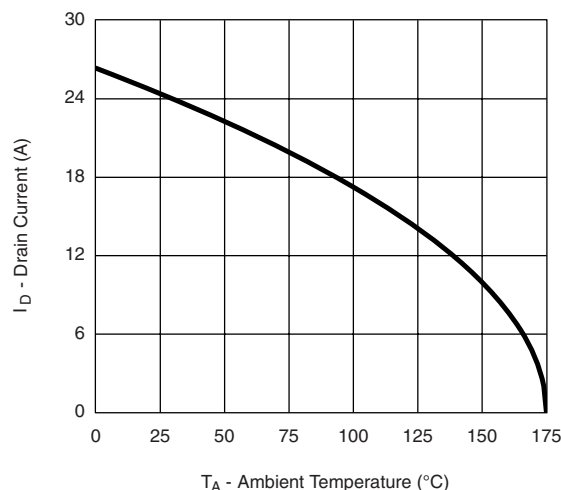


* $V_{GS} >$ minimum V_{GS} at which $r_{DS(on)}$ is specified

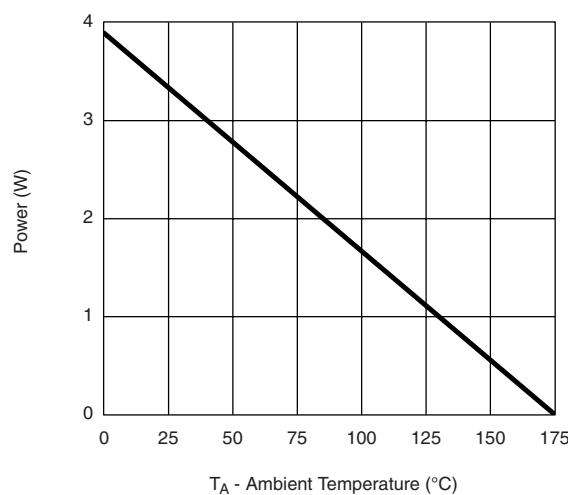
Safe Operating Area, Junction-to-Case



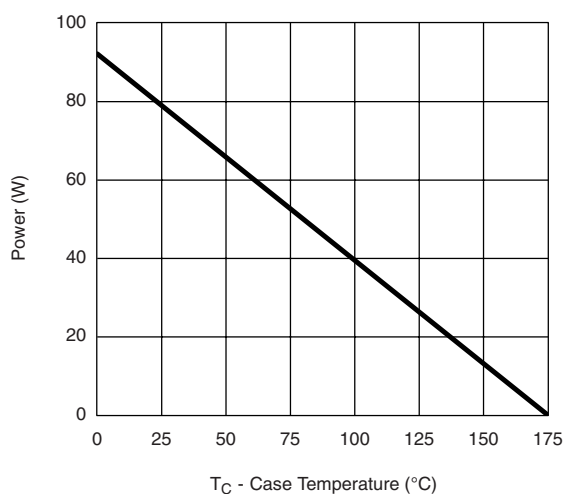
Current Derating, Junction-to-Case**



Current Derating, Junction-to-Ambient**



Power Derating, Junction-to-Ambient**



Power Derating, Junction-to-Case**

** The power dissipation P_D is based on $T_{J(max)} = 175\text{ }^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

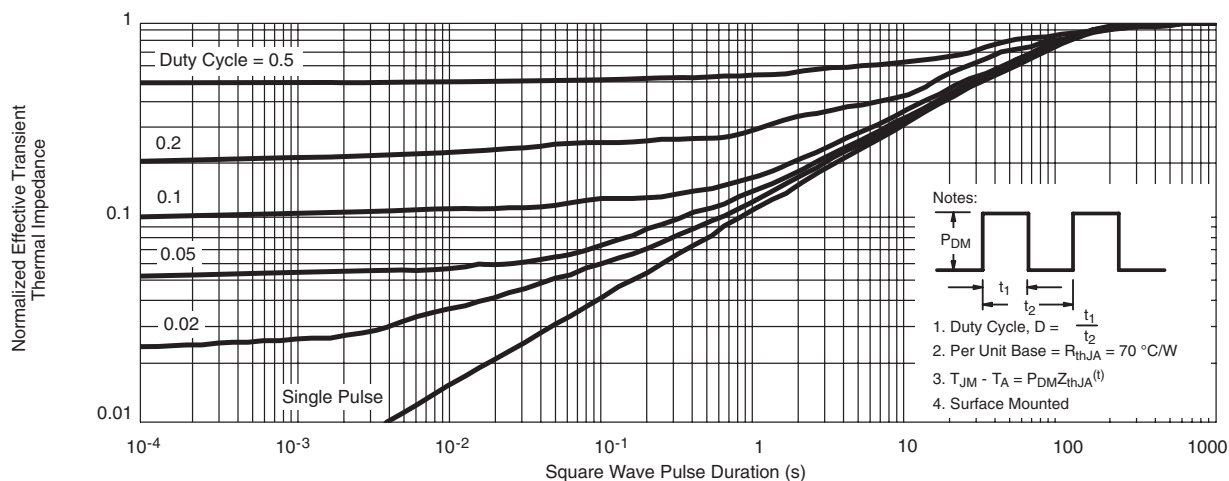
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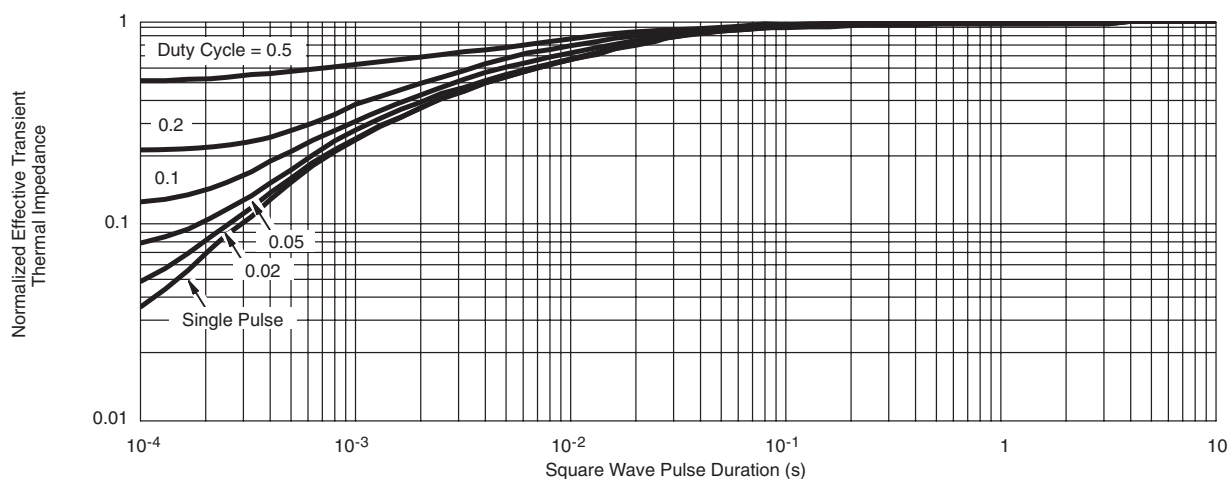
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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